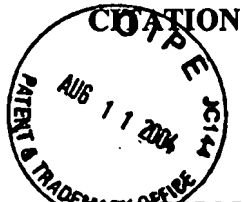


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| INFORMATION DISCLOSURE  | Atty. Docket No.: 53868US05 | Serial No.: 10/790,965 |
| | Applicant(s): Jathan D. Edwards and Donald J. Kerfeld | |
| | Filing Date: 03/02/2004 | Group: 4756 1722 |

U.S. PATENT DOCUMENTS

| Examiner Initial | Document Number | Date | Name | Class | SubClass | Filing Date If Appropriate |
|------------------|-----------------|-------|-----------------|-------|----------|----------------------------|
| /DB/ | 3,565,978 | 02/71 | Folger et al. | | | |
| /DB/ | 4,150,398 | 04/79 | Kojima et al. | | | |
| /DB/ | 4,304,806 | 12/81 | Anderson et al. | | | |
| /DB/ | 4,308,337 | 12/81 | Roach et al. | | | |
| /DB/ | 4,374,077 | 02/83 | Kerfeld | | | |
| /DB/ | 4,519,065 | 05/85 | Lewis et al. | | | |
| /DB/ | 4,619,804 | 10/86 | Leonard et al. | | | |
| /DB/ | 4,650,735 | 03/87 | De Laat | | | |

FOREIGN PATENT DOCUMENTS

| | Document Number | Date | Country | Class | Sub-Class | Translation | |
|------|-----------------|-------|----------------------|-------|-----------|---------------|----|
| | | | | | | Yes | No |
| /DB/ | 0 418 897 A2 | 03/91 | European Pat. Office | | | | |
| /DB/ | 0 444 367 A1 | 09/91 | European Pat. Office | | | | |
| /DB/ | DE 41 40 712 A1 | 10/92 | Germany | | | Abstract Only | |
| /DB/ | 60-029950 | 02/85 | Japan | | | Abstract Only | |
| /DB/ | 64-023440 | 01/89 | Japan | | | X | |

OTHER DOCUMENTS (Including Authors, Title, Date, Pertinent Papers, etc.)

| | | |
|------|--|---|
| DB | | F. Dill et al., "Characterization of Postive Photoresist," IEEE Transactions on Electron Devices, Vol. ED-22, No. 7, July 1975, pp. 445-452. |
| /DB/ | | E. O. Keizer, "VideoDisc Mastering," RCA Review, Vol. 39, No. 1, March 1978, pp. 60-86. |
| DB | | P. Trefonas III et al., "New Principle for Image Enhancement in Single Layer Positive Photoresists," SPIE Vol. 771, <i>Advances in Resist Technology and Processing IV</i> , March 1987, pp. 194-210. |
| /DB/ | | S. Nakamura et al., "High Density Recording for Magneto-optical Disk Drive," IEEE Transactions on Magnetics, Vol. 34, No. 2, March 1998, pp. 411-413. |

| | | | |
|----------|-------------------|-----------------|------------|
| EXAMINER | /Dimple Bodawala/ | Date Considered | 05/14/2007 |
|----------|-------------------|-----------------|------------|

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| INFORMATION DISCLOSURE CITATION | Atty. Docket No.: 53868US05 | Serial No.: 10/790,965 |
| | Applicant(s): Jathan D. Edwards and Donald J. Kerfeld | |
| | Filing Date: 03/02/2004 | Group: 1756 1722 |

U.S. PATENT DOCUMENTS

| Examiner Initial | Document Number | Date | Name | Class | SubClass | Filing Date If Appropriate |
|------------------|-----------------|-------|------------------|-------|----------|----------------------------|
| /DB/ | 5,096,563 | 03/92 | Yoshizawa et al. | | | |
| /DB/ | 5,149,607 | 09/92 | De Graaf et al. | | | |
| /DB/ | 5,325,353 | 06/94 | Sasaki et al. | | | |
| /DB/ | 5,381,394 | 01/95 | Yanagawa | | | |
| /DB/ | 5,436,885 | 07/95 | Okumura et al. | | | |
| /DB/ | 5,516,469 | 05/96 | Santoh et al. | | | |
| /DB/ | 5,576,918 | 11/96 | Bar-Gadda et al. | | | |
| /DB/ | 5,581,539 | 12/96 | Horie et al. | | | |
| /DB/ | 5,626,941 | 05/97 | Ouano | | | |
| /DB/ | 5,635,267 | 06/97 | Yamada et al. | | | |
| /DB/ | 5,701,288 | 12/97 | Seong | | | |
| /DB/ | 5,723,033 | 03/98 | Weiss | | | |
| /DB/ | 5,739,972 | 04/98 | Smith et al. | | | |

FOREIGN PATENT DOCUMENTS

| | Document Number | Date | Country | Class | Sub-Class | Translation | |
|------|-----------------|-------|---------|-------|-----------|---------------|----|
| | | | | | | Yes | No |
| /DB/ | 2-10536 | 01/90 | Japan | | | X | |
| /DB/ | 2-150325 | 06/90 | Japan | | | Abstract Only | |
| /DB/ | 2-244440 | 09/90 | Japan | | | X | |
| /DB/ | 6-60441 | 03/94 | Japan | | | X | |
| /DB/ | 59-193560 | 11/94 | Japan | | | Abstract Only | |
| /DB/ | 8-147768 | 06/96 | Japan | | | X | |

| | | | |
|-----------------|-------------------|------------------------|------------|
| EXAMINER | /Dimple Bodawala/ | Date Considered | 05/14/2007 |
|-----------------|-------------------|------------------------|------------|

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| INFORMATION DISCLOSURE CITATION | | Atty. Docket No.: 53868US05 | | | Serial No.: 10/790,965 | | |
| | | Applicant(s): Jathan D. Edwards and Donald J. Kerfeld | | | | | |
| | | Filing Date: 03/02/2004 | | | Group: 1766 1722 | | |
| U.S. PATENT DOCUMENTS | | | | | | | |
| Examiner Initial | | Document Number | Date | Name | Class | SubClass | Filing Date If Appropriate |
| /DB/ | | 5,751,510 | 05/98 | Smith et al. | | | |
| /DB/ | | 5,763,037 | 06/98 | Ohtomo et al. | | | |
| /DB/ | | 5,889,756 | 03/99 | Ichihara et al. | | | |
| /DB/ | | 5,949,587 | 09/99 | Takamizawa et al. | | | |
| /DB/ | | 6,183,829 | 02/01 | Daecher et al. | | | |
| /DB/ | | 6,190,838 | 02/01 | Kerfeld | | | |
| /DB/ | | 6,324,139 | 11/01 | Nakane | | | |
| | | | | | | | |
| | | | | | | | |
| FOREIGN PATENT DOCUMENTS | | | | | | | |
| | | Document Number | Date | Country | Class | Sub- Class | Translation |
| | | | | | | | Yes No |
| /DB/ | | 08-306080 | 11/96 | Japan | | | X |
| /DB/ | | 97097452 | 04/97 | Japan | | | X |
| /DB/ | | 97138981 | 05/97 | Japan | | | X |
| /DB/ | | WO 00/48172 | 08/00 | WIPO | | | |
| OTHER DOCUMENTS (Including Authors, Title, Date, Pertinent Papers, etc.) | | | | | | | |
| | | | | | | | |
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| EXAMINER /Dimple Bodawala/ | | | | Date Considered 05/14/2007 | | | |

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